Notice of References Cited	Application/Control No. 10/681,816	Applicant(s)/Patent Under Reexamination GONZALEZ, PATRICK F.	
	Examiner Scott Egan	Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,027,087	04-2006	Nozaki et al.	348/231.99
*	B	US-6,900,831	05-2005	Nishiwaki, Kenya	348/208.5
*	C	US-2005/0078194	04-2005	Gonzalez, Patrick F.	348/222.1
*	D	US-2004/0070679	04-2004	Pope, David R.	348/231.99
*	E	US-2005/0001908	01-2005	Lee, Steven K.	348/231.2
*	F	US-7,154,541	12-2006	Kondo et al.	348/222.1
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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